


<b>Search Notes</b>  	<b>Application/Control No.</b>  10573074	<b>Applicant(s)/Patent Under Reexamination</b>  OGUCHI ET AL.
	<b>Examiner</b>  PHUONG HUYNH	<b>Art Unit</b>  2857

SEARCHED			
Class	Subclass	Date	Examiner
702	59-62, 121-123	10/29/2009	PH
updated	above	04/05-06/2010	PH
702	187-189	04/05-06/2010	PH

SEARCH NOTES		
Search Notes	Date	Examiner
Assignment data (Edan)	10/29/2009	PH
Review 371P document in eDan	11/2/2009	PH
702/59-62, 121-123 with text	10/29/2009	PH
combined citation	11/03/2009	PH
702/59-62, 121-123, 187-189 with text	4/56/2010-	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
702	59,121-123	04/06/2010	PH

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